

Notice of References Cited

Application/Control No.

09/753,666

Applicant(s)/Patent Under
Reexamination
TAKAYAMA ET AL.

Examiner

Emmanuel S. Luk

Art Unit

1722

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3947208	03-1976	Broderick	425/436R
	B	US-4065001	12-1977	Ohnaka	414/733
	C	US-4299533	11-1981	Ohnaka	198/750.12
	D	US-5222409	06-1993	Dalakian	74/479.01
	E	US-5640883	06-1997	Takizawa	74/490.04
	F	US-5794487	08-1998	Solomon et al	74/490.03
	G	US-5860331	01-1999	Hashimoto et al	74/640
	H	US-6105454	08-2000	Bacchi et al	74/490.03
	I	US-6386859 B1	05-2002	Hehl	425/556
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.